

**Search Notes**

Application/Control No.

10/628,224

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	373-376; 333.06	6/24/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB text search - see search history printout		9/28/2007	NT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	6/24/2007	NT
348/14.01-14.16 348/333.01-333.12 (text search - see search history printout)	9/27/2007	NT
all class 379 (text search - see search history printout)	9/27/2007	NT
455/550.1, 556.1, 566 (text search - see search history printout)	9/28/2007	NT
Text search all classes in the databases listed above.	9/28/2007	NT
Inventorship search - see search history printout	9/28/2007	NT